- BENNETT, M. J. & FOXMAN, B. M. (1967). MMMR, Rigidbody analysis programme. Massachusetts Institute of Technology, Cambridge, Massachusetts.
- BERNDT, A. F. & MARSH, R. E. (1963). Acta Cryst. 16, 118-123.
- BIJVOET, J. M. & KETELAAR, J. A. A. (1932). J. Amer. Chem. Soc. 54, 625–628.
- BROWN, G. M. & CHIDAMBARAM, R. (1973). Acta Cryst. B29, 2393–2403.
- CHIDAMBARAM, R. & BROWN, G. M. (1973). Acta Cryst. B29, 2388–2392.
- CHURCHILL, M. R. & O'BRIEN, T. A. (1969). J. Chem. Soc. A, pp. 1110–1115.
- Cox, E. G., CRUICKSHANK, D. W. J. & SMITH, J. A. S. (1958). Proc. Roy. Soc. A247, 1–21.
- CRUICKSHANK, D. W. J. (1956). Acta Cryst. 9, 754–756.
- CRUICKSHANK, D. W. J. (1960). Acta Cryst. 13, 774-777.
- CRUICKSHANK, D. W. J. (1965). Computing Methods in Crystallography. Edited by J. S. ROLLETT, pp. 112–116. New York: Pergamon Press.
- CRUICKSHANK, D. W. J., JONES, D. W. & WALKER, G. (1964). J. Chem. Soc. pp. 1303–1314.
- DUCKWORTH, J. A. K., WILLIS, B. T. M. & PAWLEY, G. S. (1970). Acta Cryst. A 26, 263-271.
- FOXMAN, B. M. & BENNETT, M. J. (1967). SFLS5R, Fullmatrix structure-factor and least-squares programme. Massachusetts Institute of Technology, Cambridge, Massachusetts.
- HAMILTON, W. C. (1965). Acta Cryst. 18, 502-510.
- HAMILTON, W. C., EDMONDS, J. W., TIPPE, A. & RUSH, J. J. (1969). Discuss. Faraday Soc. 48, 192–204.
- HARDGROVE, G. L. & TEMPLETON, D. H. (1959). Acta Cryst. 12, 28–32.

- HOLM, C. H. & IBERS, J. A. (1959). J. Chem. Phys. 30, 885-888.
- HUTCHEON, W. L. (1971). Ph.D. Thesis, Univ. of Alberta.
- JOHNSON, C. K. (1969). Acta Cryst. A25, 187-194.
- JOHNSON, C. K. & LEVY, H. A. (1974). In *International Tables for X-ray Crystallography*, Vol. IV. Birmingham: Kynoch Press.
- JONES, T. A. (1968). J. Sediment. Petrol. 38, 61-67.
- KAY, M. I. & CROMER, D. T. (1970). Acta Cryst. B26, 1349-1355.
- KING, M. V. & LIPSCOMB, W. N. (1950). Acta Cryst. 3, 155–158.
- LA PLACA, S. J. & IBERS, J. A. (1965). Acta Cryst. 18, 511-519.
- MASLEN, E. N. (1970). In Crystallographic Computing, Edited by F. R. AHMED, pp. 231–239. Copenhagen: Munksgaard.
- MISES, R. VON (1918). Phys. Z. 19, 490-499.
- PAWLEY, G. S. (1963). Acta Cryst. 16, 1204-1208.
- PAWLEY, G. S. (1966). Acta Cryst. 20, 631-638.
- PAWLEY, G. S. & WILLIS, B. T. M. (1970). Acta Cryst. A 26, 260–262.
- PREWITT, C. T. (1966). SFLS5, Full-matrix structure factor and least-squares programme. E. I. du Pont de Nemours and Company, Wilmington, Delaware.
- SCHOMAKER, V. & TRUEBLOOD, K. N. (1968). Acta Cryst. B24, 63-76.
- SCHUNN, R. A., FRITCHIE, C. J. & PREWITT, C. T. (1966). Inorg. Chem. 5, 892–899.
- STEPHENS, M. A. (1963). Biometrika, 50, 385–390.
- STEWART, R. F., DAVIDSON, E. R. & SIMPSON, W. I. (1965). J. Chem. Phys. 42, 3175-3187.
- WILLIS, B. T. M. & PAWLEY, G. S. (1970). Acta Cryst. A 26, 254–259.

Acta Cryst. (1975). A31, 494

Accurate Positional and Thermal Parameters of Hexamethylenetetramine from K-Shell X-ray Diffraction Data

BY E. D. STEVENS* AND H. HOPE

Department of Chemistry, University of California, Davis, California 95616, U.S.A.

(Received 9 December 1974; accepted 5 February 1975)

Geometric and thermal parameters for hexamethylenetetramine have been determined from 95 unique reflections (Mo $K\alpha$, graphite monochromator) in the sin θ/λ range 0.65–1.10 Å⁻¹. Both standard (second cumulant) anisotropic thermal parameters and third cumulant parameters as well as positional parameters for C and N are in excellent agreement with the corresponding neutron parameters. H atom parameters were not determined from the X-ray data. The estimated standard deviations for the X-ray parameters are generally one fifth (or less) of those for the neutron parameters. This study shows that with X-ray data it is possible to determine geometric and thermal parameters free of effects from valence electron asphericity.

Introduction

Recent interest in the experimental determination of molecular electron density distributions has renewed

interest in the comparison of X-ray and neutron diffraction results. The aspherical electron distribution of atoms in molecules will influence parameters refined from conventional X-ray data. In a survey, Hamilton (1969) found significant differences between X-ray and neutron results in all cases.

When the positional and thermal parameters deter-

^{*} Present address: Department of Chemistry, State University of New York, Buffalo, N.Y. 14214, U.S.A.

mined from neutron diffraction are used with X-ray data to calculate a difference electron density map, the difference density represents the redistribution which occurs as a result of bonding.

An alternative approach in determining electron density distributions is to use parameters refined from high-order X-ray data rather than neutron parameters (Stewart, 1968). An inspection of atomic scattering factors suggests that C and N valence electrons will not contribute significantly to X-ray scattering above 0.65 Å^{-1} (sin θ/λ). If the core electrons are not significantly affected by bonding and if bonding features do not contribute to high-order scattering, the results of an accurate high-order refinement should be free of bias from the aspherical distribution of valence electrons and should show no systematic differences from neutron diffraction results.

X-ray data have been collected from a single crystal of hexamethylenetetramine (HMT) to test the hypothesis that high-order refinements of X-ray data will yield the same results as neutron diffraction data. The accurate neutron diffraction study by Duckworth, Willis & Pawley (1970) is available for comparison.

Experimental

Crystals of hexamethylenetetramine (J. T. Baker Chemical Co.) were grown from a 95% ethanol solution in a convection tube (Hope, 1971b). A crystal was ground into a sphere of diameter 0.45 mm, coated with a thin layer of glue to prevent sublimation, and mounted on a Picker automated four-circle diffractometer equipped with an incident-beam graphite monochromator. The angular coordinates ($\chi, \omega, 2\theta$) of 15 Mo K α_1 reflections were used in a least-squares calculation to determine the crystal orientation and cell dimensions. The cell edge was found to be $a_0 =$ 7.028 (2) Å at 24°C with $\lambda = 0.70926$ Å for Mo K α_1 radiation.

The positional and thermal parameters determined by neutron diffraction (Duckworth *et al.*, 1970) were used together with sample scan and background measurements to predict which reflections would have measurable X-ray intensities. The setting angles χ , φ , and ω were chosen to minimize the contributions of multiple Bragg scattering using a procedure similar to that of Coppens (1968). For each reflection, a rotation ψ about the diffraction vector was chosen which would avoid contact of all other observed reflections with the sphere of reflection.

The intensities of 1251 selected reflections were measured using a $\theta:2\theta$ scan, graphite monochromatized Mo $K\alpha_1$ radiation, and a scintillation detector with a pulse-height analyzer. Each reflection was scanned from $[2\theta(\alpha_1) - 0.8^\circ]$ to $[2\theta(\alpha_2) + 0.7^\circ]$ with a scan speed of $0.25^\circ(2\theta)/\text{min}$. Background counts were taken for 100 s at each end of the scan range. Coincidence losses were minimized by adding an attenuator filter when the count rate exceeded 10000 c.p.s. Two check reflections were measured after every 50 reflections and showed a gradual decline in intensity, probably caused by sublimation, amounting to 10% at the end of data collection. A correction for this was obtained from a single linear least-squares fit of the normalized intensities of both check reflections. Each recorded number of counts, N, was assigned a standard deviation $\sigma(N) = [N + (0.0065N)^2]^{1/2}$; the factor 0.0065 reproduces the observed variance in the check reflections after correction for decay. Based on the values of $\sigma(N)$ for scan and background counts, e.s.d.'s for the net intensities were calculated.

Lorentz and polarization corrections were applied to the net intensities. The polarization factor includes the polarization by the monochromator crystal (Hope, 1971*a*). Each measured intensity I_{obs} was corrected for first (α_1) and second order (α_2) thermal diffuse scattering included in the scan

$$I_{\text{Bragg}} = I_{\text{obs}} / (1 + \alpha_1 + \alpha_2)$$
.

The correction was calculated using a procedure described by Stevens (1974) which includes the $K\alpha_1$, $K\alpha_2$ wavelength distribution, the elastic anisotropy, and the orientation of the crystal defined by the χ , φ , and ω angles. The elastic constants of HMT have been measured by Haussühl (1958). The horizontal and vertical detector slits each subtended an angle of 1°. Each correction was calculated with a precision of 0.1%. The largest value was 0.30 for α_1 and 0.07 for α_2 .

At least six symmetry equivalent forms of each independent reflection were measured. The intensities and e.s.d.'s of the symmetry equivalent forms were used to calculate a weighted average intensity, e.s.d. of the mean, as well as external ('observed') standard deviation for each independent reflection. For most reflections, the external e.s.d.'s were less than the average e.s.d.'s from counting statistics. However, for weak and very strong reflections the external e.s.d.'s were larger.

Refinement

The quantity $\sum w(F_{obs} - K|F_{cal}|)^2$ was minimized in a full-matrix least-squares refinement, with $w = 1/\sigma^2$ where σ is the e.s.d. for the mean of each observed structure factor. The data were divided into two groups: a low-order group with $0.0 < \sin \theta/\lambda \le 0.65$ Å⁻¹, and a high-order group with $0.65 < \sin \theta/\lambda < 1.10$ Å⁻¹. Both groups were refined separately.

Refinements were performed with two descriptions of the thermal motion, (1) with conventional anisotropic thermal parameters where the structure factor is given by

$$F_c^{(2)} = \sum_p f^{(p)} \exp\left(2\pi i x_i^{(p)} h_i\right) \exp\left[-\frac{1}{4} (B_{ij} a_i^* a_j^* h_i h_j)\right],$$

and (2) with third cumulant thermal parameters (Johnson, 1969), where the structure factor is given by

$$F_{c}^{(3)} = \sum_{p} F_{c}^{(2,p)} \exp\left(-iC_{ijk}^{(p)}a_{i}^{*}a_{j}^{*}a_{k}^{*}h_{i}h_{j}h_{k}\right) \ (i,j,k=1,2,3),$$

where \sum_{p} implies summation over all atoms in the unit

cell, the subscripts *i*, *ij* and *ijk* imply single, double and triple summation, respectively and $F_c^{(2,p)}$ is the singleatom contribution to $F_c^{(2)}$. The other symbols have their conventional meanings.

Refinements of type (1) were carried out with both relativistic Hartree–Fock (RHF) and Slater-type orbital form factors.

Scattering factors calculated by Doyle & Turner (1968) were used for nitrogen and carbon. The contracted spherical scattering factor calculated by Stewart, Davidson & Simpson (1965) was used for hydrogen.

During initial refinement, inspection of the deviations between F_o and F_c indicated secondary extinction in the 011 reflection, which has an intensity more than four times greater than the intensity of the next strongest reflection. The reflection was not included in further refinements. All other reflections were considered to be 'observed'.

Since hydrogen does not scatter sufficiently at high angles hydrogen parameters in the high-order refinement were fixed at the values determined by neutron diffraction. The results of type (1) refinements of the X-ray data are compared with the neutron diffraction results in Table 1. Molecular optimized scattering factors (MOSTO) for carbon and nitrogen were calculated from Slater-type orbital exponents optimized to the methane and ammonia molecules, respectively, by Hehre, Stewart & Pople (1970). The results of refinement of the X-ray data with third-cumulant thermal parameters are compared with a third-cumulant refinement of the neutron data in Table 2. A significant improvement in the model results from third cumulant refinements for both high-and low-order data, as judged by Hamilton's (1965) R-factor ratio test.

The parameters from each of the X-ray refinements are compared with the neutron diffraction results using the chi-squared test of Hamilton (1969). Included in each table is the value of χ^2 required for differences in the parameters to be significant at the 0.05 level.

Table 3 gives a comparison of F_o and F_c . The calculated structure factors are based on the high-order refinement with standard anisotropic temperature factors, using RHF form factors.

Discussion

The differences between the low-order X-ray parameters and the neutron parameters are significant and can be attributed to the aspherical distribution of valence electrons. Surprisingly, in our study the nitrogen is not displaced towards the lone pair, in contrast to the results of the previously reported X-ray work (Becka & Cruickshank, 1963).

The hypothesis that the differences between the high-order X-ray parameters and neutron parameters are due to random errors cannot be rejected as indicated by the χ^2 test. In this structure, the nuclear positions and thermal parameters coincide with those

Form factor	RHF	RHF	MOSTO	MOSTO	Neutron
Sin θ/λ range (Å ⁻¹) Number of parameters Number of reflections R(%) $R_w(\%)$ Goodness of fit Scale for F_o χ^2_{obs} $\chi^2_{0,os}$ $(\%-\%) = e^*$	0.0-0.65 14 54 2.86 3.55 12.96 0.0258 (1) 187.1 22.4 1.62°	0.65-1.10 8 95 6.35 3.76 3.31 0.0280 (1) 4.4 14.1 1.88°	0.0-0.65 14 54 2.49 3.23 11.74 0.0280 (1) 185.5 22.4	0.65-1.10 8 95 6.31 3.68 3.41 0.0279 (1) 5.2 14.1	0·0-0·8 14 49 2·33
Nitrogen					
$\begin{array}{c} x, y, z \\ B_{11, 22, 33} \\ B_{12, 13, 23} \end{array}$	0·1223 (1) 4·13 (3) -0·79 (2)	0.1223 (1) 3.84 (2) -0.83 (1)	0·1221 (1) 3·74 (2) -0·77 (1)	0·1223 (1) 3·80 (2) -0·83 (1)	0.1222 (2) 3.87 (6) -0.81 (6)
Carbon					
x B ₁₁ B _{22, 33} B ₂₃	0·2382 (1) 2·53 (2) 5·40 (3) 0·27 (4)	0·2378 (1) 2·11 (2) 5·04 (3) 0·04 (3)	0·2384 (1) 2·34 (2) 5·25 (3) -0·35 (4)	0·2378 (1) 2·08 (2) 5·01(3) 0·04 (3)	0·2370 (5) 2·04 (12) 5·11 (12) 0·02 (20)
Hydrogen					
x, y z $B_{11, 22}$ B_{33} B_{12}	$\begin{array}{c} 0.0898 \ (8) \\ -0.3187 \ (7) \\ 7.36 \ (36) \\ 3.42 \ (21) \\ -0.66 \ (32) \end{array}$	[0·0909] [0·3266] [8·77] [4·07] [0·42]	$\begin{array}{r} 0.0905 (7) \\ -0.3215 (7) \\ 6.73 (32) \\ 3.68 (20) \\ -1.43 (27) \end{array}$	[0·0909] [-0·3266] [8·77] [4·07] [-0·42]	0.0909 (6) - 0.3266 (7) 8.77 (28) 4.07 (22) - 0.42 (32)
B _{13, 23}	4.06 (21)	[1.88]	4.43 (19)	[1.88]	1.88 (16)

Table 1. Comparison of refinements with standard (second-cumulant) temperature factors

* φ_X and φ_N are X-ray and neutron phase angles respectively.

Fable	2.	Comparison	of	refinen	nents	with	third-cumulant	t	
		2. Comparison of refinements with third-cumulant temperature factors							

	-	-	
Form factor	RHF	RHF	Neutron
$\sin \theta / \lambda$ range (Å ⁻¹) 0.0-0.65	0.65-1.10	0.0-0.8
Number of parameters	25	13	25
Number			10
of reflection	ns 54	95	49
R(%)	1.46	5.21	1.18
$R_{w}(\%)$	1.26	2.39	
Goodness of	fit 4·47	2.28	
Scale for F _o	0.0260 (1)	0.0273(1)	
Xobs	166.4	6.4	
Xố,05	36.4	21.0	
Nitrogen			
x, y, z	0.1221(1)	0.1224(2)	0.1225 (4)
B _{11, 22, 33}	4.06 (1)	3.88 (2)	3.89 (6)
B _{12, 13, 23}	-0.81(1)	-0.83(1)	-0.81(6)
C_{111} , 222, 333	0·027 (6)	0.031 (4)	0.028 (55)
C112, 113, 122	-0.013(2)	-0.012(2)	-0.003(35)
133, 223, 233			()
C_{123}	0.104 (5)	0.020 (2)	-0.007 (55)
Carbon			
x	-0.2369(2)	0.2358(2)	0.2356(8)
B ₁₁	2.40(2)	2.14(1)	2.00(12)
B ₁₂ 22	5.45(1)	5.13(2)	5.02(12)
B_{12}	-0.22(2)	0.01(2)	-0.02(12)
-23 Cui	-0.004(10)	-0.024(5)	-0.111(49)
C_{122} C_{123}	-0.052(4)	-0.046(2)	-0.055(35)
$C_{122}, 233$ C_{123}	[00.0]	[0.00]	[0.000]
Hydrogen	[]	[0 00]	[0 000]
	0.0874 (8)	[0.0004]	0.0004 (8)
л, у 7	-0.3155(8)	[0.3220]	0.0304(0)
² R	8.00 (20)	[0.3229]	-0.3229(12) 8.60(24)
$B_{11, 22}$	3.15(17)	[4.60]	$\frac{3.00}{24}$
D33 B.	0.46(20)	[4:00]	-0.51(24)
B_{12}	3.18(17)	[2.00]	-0.31(24) 2.00(14)
$D_{13, 23}$	0.083(97)	[2 00] [_0.166]	-0.166(94)
C111, 222	0.086(83)	[0.253]	0.253 (00)
C	0.149(61)	[0.000]	0.000 (55)
Cu2	0.504(44)	[0.219]	0.210 (60)
C113, 223	0.203(35)	[0.142]	0.142(55)
C133, 233	0.021(65)	[0.045]	0.045(62)
			0 0 1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0

of the core electrons determined by the high order X-ray scattering.

The goodness of fit parameter,

$$S = [\sum w(\Delta F)^2/(n-m)]^{1/2}$$

for the high-order refinement is considerably closer to the value of 1.0 expected if model errors are insignificant. This is attributed to the fact that the sphericalatom model used in the refinement is a better representation of the electron distribution in the high-order refinement where the scattering is due to the core electrons.

The third-cumulant refinement of low-order X-ray data yields parameters which are significantly different from the parameters of the third cumulant neutron refinement. The third-cumulant parameters are expected to be strongly influenced by the valence elec-

Table 3. Observed and calculated structure amplitudes

 F_c is based on second cumulant refinement of high-order data. L denotes low-order data. The columns are l, $100|F_o|$, $100|F_c|$ and $1/\sigma(F_o)$.

								13	42				2. 14						
		۰.		**	0, 1.	٠		15	17	- 25	1.		1841	115		10	~ ~	· •	••
- 1	1.001	1742	- 77	•	326L	30P	119					ì	24.61						
	2.1				31	47	40		1	•		•	74	•;;	14			·	
	346		32	10	30	1+	40		257L	245	71	11	48		24				112
		• • • •	- 22					•	**	73	45	- 13	72	- ż1	36	i.			
					· · ·	1.		10	59	54	40								•••
	~					21	11	17	**	• • •	51		2, 20				4	•	
					- 113	115	71						501L	487	71	s	7.0		14
~.		·				27	22	ו	3 e . Ku	•			33	33		,	107		
									270	247	89	10	115	113	71	•	145	15.8	
;	1016		142		•••••	•			54	58	89					11			
				•	217	417	••	- 11	50	- 50	40		2. K.	,				••	
			- 11			-		- 13	23	16	20	,	176	1,4	89		41 84		
						,						•	71	71	27				**
				,		•+	76	H.	1	,		11	48	>1	27	é	61		14
			10						\$13	101	•0					10	76	7.	
					1	· · · ·		10	50	48	26	**	7, KO						"
		f			230er	2040	12						92	63			4. 84	,	
	12110		40	•	300L	74	30	H.	3 · K#									·	
- 1	003L			•	- 2111	479	51	•	102	101	45		2						2.
		104	117		4411	** :	71					•	17	11	27		4. 44		
	7210		117	10	132	144	45	ו	2+ K+	2					•			·	
10		174		12	20	33	30	,	42246	4037	3		1						
17		54	30	14	31	24	17		405L	374	179	•	2221	264	119	10			
									10081	1059	60	6	4971				•••		
				**	14.80	2			64	51	32	à	2351	2/0			A		
	110/4	10/1	10	,	12201	1448	45	10	737	241	71	10	80			<i></i> ,		·	
- 2			27	•	4871	454	119	17	30	36	12			•.				- 12	117
	3120	200	179		4416	4.85	119	- j4	29	32	32		1						
•	20	73	32	•	164	111	45					1	1201	166	45		•7	-0	36
		21		11	147	143	179		2	,		•	211						
13			40		52	54	51	,	1775	1147	60	11						·	• •
15	35	**	1.0	15	28	Ja	24	•	4661	480	69	- 14	25						1
								,	4130	434	89				•••				
		·			1	3		•	120	175	•0		3, 80	5			216		
	220 JL	2211	12		10411	1030	51	11	*5	**	119		259L		119	16		· ;;;	112
	1.001	122			445L	464	P.4	13		45	27		237				•		.,
		27			171	27	10	15	24	28	30	10	7.						
10				10	141	124										1	1.04	1.22	
	114	111	•••	12	76	7.	71	H.	2. Ko	4			3						
									4721	472	60	,	1.10		**				
		·			14 84	•.			700L	270		•	64			~		- A1	- 6
- 2	7074	124	46			844	34	,	166	141	69	11	75	12		•			30
	1700	1.1	•0		1466	101	71	16	50		30								
		- 22	- 17		60	**	71	12		47	2		20.84	,					
			70	11.	20	12	10				-	1.0							

tron density distribution. The high-order X-ray parameters, however, are not significantly different from the neutron values. The ability of a refinement of highorder X-ray data to reproduce the positional and thermal parameters determined by neutron diffraction even when third-cumulant thermal parameters are refined indicates that, in this case, bonding features such as lone pairs do not contribute to high-order scattering and the core electrons are not influenced by the valence electron distribution.

The difference between X-ray scale factors refined in the low- and high-order refinements is primarily due to the use of atomic scattering factors calculated from isolated-atom Hartree–Fock wavefunctions. When scattering factors are used which have been calculated from molecular optimized Slater-type orbitals there is no significant difference in the X-ray scale factors.

The low-order X-ray refinement with molecular optimized atomic scattering factors gives better agreement with the neutron refinement than the refinement with Hartree–Fock scattering factors. The agreement of the high-order refinement is not affected.

A difference electron density map calculated from X-ray data and neutron positional and thermal parameters should show the redistribution of electron density in a molecule as a result of bonding. The appearance of the map is strongly dependent on the scale factor used for the X-ray data. The scale factors determined from high-order refinements and from the low-order refinements using molecular optimized atomic scattering factors agree within experimental error with an experimental measurement of the scale factor (Stevens & Coppens, 1974).

A difference density map calculated with the X-ray data and neutron positional and thermal parameters is plotted in Fig. 1(a). The unique section of the (110) plane is shown with the carbon-nitrogen bond indicated at the top of the figure and the carbon-hydrogen bond indicated at the bottom. The threefold





Fig. 1. Difference electron density, 110 plane (a) X-N difference map. (b) X-X (high-order) difference map.

axis lies in the plane and passes through the upper left corner and lower right corner.

The lone-pair density of the nitrogen atom is clearly visible extending from the nitrogen along the threefold axis. Bonding density is also present in the carbonnitrogen and carbon-hydrogen bond region.

A difference density map calculated with the X-ray data and the positional and thermal parameters from the high-order X-ray refinement is plotted in Fig. 1(b). Since there is no significant difference in the results of the neutron and the high-order X-ray refinements, the difference density maps are nearly identical.

HMT has been used in a joint refinement of X-ray and neutron data in which separate positional parameters and common thermal parameters are refined (Duckworth, Willis & Pawley, 1969). Since the thermal parameters obtained from low-order X-ray data show greater bias due to the valence electrons than the positional parameters, these results indicate that a joint refinement with common positional parameters and separate thermal parameters would be more appropriate, although, in our opinion, the exact interpretation of the results of such refinements would be so difficult as to render them nearly useless. We do not recommend this procedure.

In this case it has been possible, using K-shell X-ray diffraction data, to obtain accurate positional and thermal parameters which are not biased by the aspherical distribution of valence electrons. In other cases (e.g. structures with oxygen atoms) scattering from lone-pair electrons may extend beyond a sin θ/λ value of 0.65 Å^{-1} , requiring higher-order data.

Support from the National Science Foundation is gratefully acknowledged.

References

- BECKA, L. N. & CRUICKSHANK, D. W. J. (1963). Proc. Roy. Soc. A 273, 435-454.
- COPPENS, P. (1968). Acta Cryst. A 24, 253-257.
- DOYLE, P. A. & TURNER, P. S. (1968). Acta Cryst. A24, 390-397.
- DUCKWORTH, J. A. K., WILLIS, B. T. M. & PAWLEY, G. S. (1969). Acta Cryst. A 25, 482-484.
- DUCKWORTH, J. A. K., WILLIS, B. T. M. & PAWLEY, G. S. (1970). Acta Cryst. A26, 263-271.
- HAMILTON, W. C. (1965). Acta Cryst. 18, 502-510.
- HAMILTON, W. C. (1969). Acta Cryst. A25, 194-206.
- HAUSSÜHL, S. (1958). Acta Cryst. 11, 58-59.
- HEHRE, W. J., STEWART, R. F. & POPLE, J. A. (1970). J. Chem. Phys. 52, 2769-2773.
- HOPE, H. (1971a). Acta Cryst. A27, 392-393.
- HOPE, H. (1971b). J. Appl. Cryst. 4, 333.
- JOHNSON, C. K. (1969). Acta Cryst. A 25, 187-194.
- STEVENS, E. D. (1974). Acta Cryst. A30, 184-189.
- STEVENS, E. D. & COPPENS, P. (1974). Unpublished result.
- STEWART, R. F. (1968). J. Chem. Phys. 48, 4882–4889. STEWART, R. F., DAVIDSON, E. R. & SIMPSON, W. T. (1965). J. Chem. Phys. 42, 3175-3187.